


<b>Search Notes</b> 	<b>Application/Control No.</b> 09932456	<b>Applicant(s)/Patent Under Reexamination</b> OEHLER ET AL.
	<b>Examiner</b> PHILIP C LEE	<b>Art Unit</b> 2453

### SEARCHED

Class	Subclass	Date	Examiner
712	1,13	12/2/10	/p/
709	202,212,213,220	12/2/10	/p/

### SEARCH NOTES

Search Notes	Date	Examiner
keywords search in EAST	12/2/10	/p/
Keywords search in 712/1,13; 709/202,212,213,220	12/2/10	/p/
Search 712/1,13;709/202,212,213,220 in PG Pub	12/2/10	/p/
Google Search	12/2/10	/p/
ACM/IEEE search	12/2/10	/p/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
712	1,13	12/2/10	/p/
709	202,212,213,220	12/2/10	/p/

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